

6/4-Bit VID Programmable Current DAC for Point of Load Regulators with Adjustable Start-Up Current

Check for Samples: LM10011

FEATURES

- 1.0% Output Current Accuracy (0°C to +100°C)
- 1.25% Output Current Accuracy (-40°C to +125°C)
- Input Voltage Range: +2.97V to +5.5V
- Pin Selectable VID Format (6/4 bit)
- 16 Selectable Start-Up Currents
- Precision Enable to Support Custom UVLO
- SON-10 3mm x 3mm Footprint, 0.5mm Pitch
- Footprint Compatible with the LM10010

APPLICATIONS

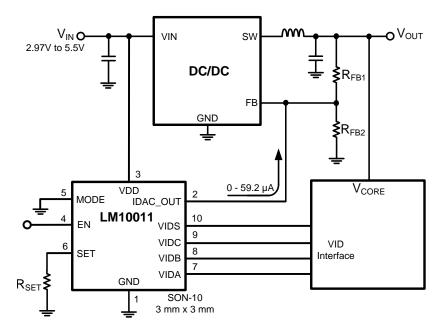
- Broadband, Networking, and Wireless Communications
- Notebook Power Solutions
- Portable Instruments
- Battery-Powered Equipment
- Powering Digital Loads with a 6-bit or 4-bit, 4
 Pin VID Interface

DESCRIPTION

The LM10011 is a precision, digitally programmable device used to control the output voltage of a DC/DC converter. The LM10011 outputs a DC current proportional to a 6-bit or 4-bit input word. By connecting the IDAC_OUT pin to the feedback node of a regulator, the regulator output voltage can be adjusted to a desired range and resolution set by the user. As the input word counts up, the output voltage is adjusted higher based on the values of the feedback resistors in the converter.

The current from the IDAC_OUT pin on start-up is programmable by an external resistor to cover the range of 0 to 56.4µA with 4 bits of resolution. The MODE pin allows programming of the device through a 4-bit parallel VID interface or through a 6-bit interface consisting of upper and lower 3-bit VID codes. The LM10011 is specifically designed to program a wide variety of Texas Instruments DC/DC converters for VID (Voltage Identification) applications.

TYPICAL APPLICATION CIRCUIT





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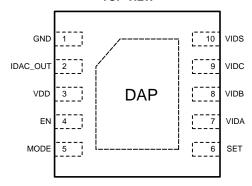




These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

CONNECTION DIAGRAM

SON-10 3mm x 3mm 0.5mm pitch TOP VIEW



PIN DESCRIPTIONS

PIN NAME NO.						
		DESCRIPTION				
GND	1	Ground.				
IDAC_OUT	2	Output pin of the current DAC that connects to the feedback node of the regulator.				
VDD 3 Positive supply input. Operating voltage is 2.97V to 5.5V. It is recommended to add a small 1nF or great bypass capacitor from this pin to GND.		Positive supply input. Operating voltage is 2.97V to 5.5V. It is recommended to add a small 1nF or greater bypass capacitor from this pin to GND.				
EN	4	Precision enable input. The LM10011 will operate when the EN pin voltage exceeds 1.34V.				
MODE	5	MODE will set the VID operating mode. Connecting MODE to VDD will select a 4-bit parallel interface. Connecting MODE to GND will select a 4 pin, 6-bit interface.				
SET	6	A resistor connected from SET to GND will set the start-up code (current) at the IDAC_OUT pin. There are 16 different start-up codes to select from.				
VIDA	7	VID digital input. In 6-bit mode: Bit 0 when VIDS transitions low; Bit 3 when VIDS transitions high. In 4-bit mode: Bit 0.				
VIDB	8	VID digital input. In 6-bit mode: Bit 1 when VIDS transitions low; Bit 4 when VIDS transitions high. In 4-bit mode: Bit 1.				
VIDC	9	VID digital input. In 6-bit mode: Bit 2 when VIDS transitions low; Bit 5 when VIDS transitions high. In 4-bit mode: Bit 2.				
VIDS	10	VID select line. In 6-bit mode: Transition low selects lower 3 bits, Transition high selects upper 3 bits and updates the IDAC_OUT current to reflect the present VID code. In 4-bit mode: Bit 3.				
DAP	DAP	Die Attach Pad. Not electrically connected to device, connect to system ground plane for reduced thermal resistance.				

ABSOLUTE MAXIMUM RATINGS(1)(2)

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
VDD, EN, IDAC_OUT, MODE		-0.3	6	V
VIDA, VIDB, VIDC, VIDS		-0.3	6	V
ESD Rating ⁽³⁾	Human Body Model		2	kV
Storage Temperature			+150	°C
Junction Temperature			+150	°C

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur.
- (2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.
- (3) The human body model is a 100 pF capacitor discharged through a 1.5kΩ resistor into each pin.

OPERATING CHARACTERISTICS

over operating free-air temperature range (unless otherwise noted)

PARAMETER	MIN	TYP MAX	UNIT
VDD	2.97	5.5	V
IDAC_OUT	-0.3	VDD-1.75	V
VIDA, VIDB, VIDC, VIDS, EN, MODE	-0.3	5.5	V
Junction Temperature	-40	+125	°C
Ambient Temperature	-40	+125	°C

THERMAL INFORMATION

		LM10011	
	THERMAL METRIC ⁽¹⁾	SON-10	UNITS
		10 PINS	
θ_{JA}	Junction-to-ambient thermal resistance ⁽²⁾	52.1	
θ_{JCtop}	Junction-to-case (top) thermal resistance (3)	30.6	
θ_{JB}	Junction-to-board thermal resistance (4)	26.8	9000
ΨЈТ	Junction-to-top characterization parameter (5)	0.9	°C/W
ΨЈВ	Junction-to-board characterization parameter ⁽⁶⁾	26.9	
θ_{JCbot}	Junction-to-case (bottom) thermal resistance (7)	7.7	

- (1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.
- (2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as specified in JESD51-7, in an environment described in JESD51-2a.
- (3) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDEC-standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.
- (4) The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.
- (5) The junction-to-top characterization parameter, ψ_{JT}, estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ_{JA}, using a procedure described in JESD51-2a (sections 6 and 7).
- (6) The junction-to-board characterization parameter, ψ_{JB}, estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ_{JA}, using a procedure described in JESD51-2a (sections 6 and 7).
- (7) The junction-to-case (bottom) thermal resistance is obtained by simulating a cold plate test on the exposed (power) pad. No specific JEDEC standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.

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ELECTRICAL CHARACTERISTICS

Limits in standard type are for $T_J = 25^{\circ}\text{C}$ only. Limits appearing in boldface type apply over the full operating junction temperature range ($-40^{\circ}\text{C} < T_J < +125^{\circ}\text{C}$). Unless otherwise noted, specifications apply to the Typical Application Circuit.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply, UVLC), and Enable					
IQ	Quiescent current	VDD=5.0V, V _{EN} =2.0V		260	300	μΑ
IQ_FS	Quiescent current, IDAC_OUT = IFS_6	VDD=5.0V, V _{EN} =2.0V, IFS_6		382		μΑ
IQ_DIS	Quiescent current disabled	VDD=5.0V, V _{EN} =0.0V		45	65	μΑ
VUVLO_R	Under voltage rising threshold	VDD Rising		2.65	2.95	V
VUVLO_F	Under voltage falling threshold	VDD Falling	2.2	2.45		V
VUVLO_HYS	Hysteresis			200		mV
VEN	Enable rising threshold	V _{EN} Rising	1.20	1.34	1.45	V
VEN_HYS	Enable hysteresis		50	100	180	mV
IEN	Enable pull-up current			2		μA
DAC_OUT						·
ACC	Accuracy	Measured at full scale	-1.25		1.25	%
ACC	Accuracy	Measured at full scale, 0°C to 100°C	-1.0		1.0	%
LSB_6	DAC step size, 6-bit mode	IFS_6/(2 ⁶ -1)		940		nA
LSB_4	DAC step size, 4-bit mode	IFS_4 /(2 ⁴ -1)		3.76		μA
IFS_6	Full-scale output current (6-bit mode)	VID[5:0] = 000000b		59.2		μA
IFS_4	Full-scale output current (4-bit mode)	VID[3:0] = 0000b		56.4		μΑ
INL	Integral non-linearity		-1		1	LSB_6
DNL	Differential non-linearity		-0.25		0.25	LSB_6
OFFSET	Offset current	VID[5:0] = 111111b (6-bit), VID[3:0] = 1111b (4-bit)		60		nA
VOUT_MAX	IDAC_OUT compliance voltage	VDD=3V, VDD-V _{IDAC_OUT}			1.75	V
Start-Up Set C	Current				"	
VSETFSR	SET pin voltage FSR		1.12	1.2	1.23	V
SETRES	SET ADC resolution			4		bits
SETRNG	SET ADC current full-scale range			56.4		μA
ISET	SET Current		4.75	5.1	5.40	μA
SET0	Start-up DAC error, code 0	$R_{SET} = 0\Omega$, $I_{DAC\ OUT} = 56.4\mu A$	0		0	LSB
SET1	Start-up DAC error, code 1	$R_{SET} = 21.0k\Omega^{(1)}, I_{DAC\ OUT} = 52.7\mu A$	0		0	LSB
SET2	Start-up DAC error, code 2	$R_{SET} = 35.7 k\Omega^{(1)}, I_{DAC_OUT} = 48.9 \mu A$	0		0	LSB
SET3	Start-up DAC error, code 3	$R_{SET} = 51.1 k\Omega^{(1)}, I_{DAC_OUT} = 45.2 \mu A$	0		0	LSB
SET4	Start-up DAC error, code 4 ⁽²⁾	$R_{SET} = 71.5k\Omega^{(1)}, I_{DAC OUT} = 41.4\mu A$	0		+1	LSB
SET5	Start-up DAC error, code 5 ⁽²⁾	$R_{SET} = 86.6k\Omega^{(1)}, I_{DAC_OUT} = 37.7\mu A$	0		+1	LSB
	Start-up DAC error, code 6 ⁽²⁾	$R_{SET} = 105k\Omega^{(1)}, I_{DAC\ OUT} = 33.9\mu A$	0		+1	LSB
SET6						LSB
	Start-up DAC error, code 7 ⁽²⁾	$R_{SET} = 118k\Omega^{(1)}$, I_{DAC} OUT = 30.1uA	0		+!	
SET7	Start-up DAC error, code 7 ⁽²⁾ Start-up DAC error, code 8 ⁽²⁾	$R_{SET} = 118k\Omega^{(1)}, I_{DAC_OUT} = 30.1\mu A$ $R_{SET} = 140k\Omega^{(1)}, I_{DAC_OUT} = 26.4\mu A$	0		+1	LSB
SET7 SET8	Start-up DAC error, code 8 ⁽²⁾	$R_{SET} = 140 k\Omega^{(1)}, I_{DAC_OUT} = 26.4 \mu A$	0		+1	LSB LSB
SET7 SET8 SET9	Start-up DAC error, code 8 ⁽²⁾ Start-up DAC error, code 9 ⁽²⁾	$R_{SET} = 140k\Omega^{(1)}, I_{DAC_OUT} = 26.4\mu A$ $R_{SET} = 154k\Omega^{(1)}, I_{DAC_OUT} = 22.6\mu A$	0		+1	LSB
SET7 SET8 SET9 SET10	Start-up DAC error, code 8 ⁽²⁾ Start-up DAC error, code 9 ⁽²⁾ Start-up DAC error, code 10 ⁽²⁾	$R_{SET} = 140 k\Omega^{(1)}, I_{DAC_OUT} = 26.4 \mu A$ $R_{SET} = 154 k\Omega^{(1)}, I_{DAC_OUT} = 22.6 \mu A$ $R_{SET} = 169 k\Omega^{(1)}, I_{DAC_OUT} = 18.8 \mu A$	0 0		+1 +1 +1	LSB LSB
SET7 SET8 SET9 SET10 SET11	Start-up DAC error, code 8 ⁽²⁾ Start-up DAC error, code 9 ⁽²⁾ Start-up DAC error, code 10 ⁽²⁾ Start-up DAC error, code 11 ⁽²⁾	$\begin{split} R_{SET} &= 140 k \Omega^{(1)}, \ I_{DAC_OUT} = 26.4 \mu A \\ R_{SET} &= 154 k \Omega^{(1)}, \ I_{DAC_OUT} = 22.6 \mu A \\ R_{SET} &= 169 k \Omega^{(1)}, \ I_{DAC_OUT} = 18.8 \mu A \\ R_{SET} &= 182 k \Omega^{(1)}, \ I_{DAC_OUT} = 15.1 \mu A \end{split}$	0 0 0 0		+1 +1 +1 +1	LSB LSB
SET7 SET8 SET9 SET10	Start-up DAC error, code 8 ⁽²⁾ Start-up DAC error, code 9 ⁽²⁾ Start-up DAC error, code 10 ⁽²⁾	$R_{SET} = 140 k\Omega^{(1)}, I_{DAC_OUT} = 26.4 \mu A$ $R_{SET} = 154 k\Omega^{(1)}, I_{DAC_OUT} = 22.6 \mu A$ $R_{SET} = 169 k\Omega^{(1)}, I_{DAC_OUT} = 18.8 \mu A$	0 0		+1 +1 +1	LSB LSB

 R_{SET} is based on 1% E96 standard resistor values. "+1" LSB implies a positive step in CODE. LSB is in reference to LSB_4. (2)

ELECTRICAL CHARACTERISTICS (continued)

Limits in standard type are for $T_J = 25^{\circ}\text{C}$ only. Limits appearing in boldface type apply over the full operating junction temperature range ($-40^{\circ}\text{C} < T_J < +125^{\circ}\text{C}$). Unless otherwise noted, specifications apply to the Typical Application Circuit.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
SET15	Start-up DAC error, code 15 $R_{SET} = 301k\Omega^{(1)}$, $I_{DAC_OUT} = 0.06\mu A$		0		0	LSB
VID Logic In	puts ⁽³⁾					
V _{IL}	Input voltage low				0.75	V
V _{IH}	Input voltage high		1.0			V
I _{IL}	Input current low		-3.5			μΑ
I _{IH}	Input current high				5	μΑ
t _{DEGLITCH}	Input deglitch time			3.6		μs
t ₁	Input delay time	VIDS rising edge			1	μs
t ₂	Input hold time VIDA, VIDB, VIDC valid	VIDS falling edge	20			μs
t ₃	Input delay time	VIDS falling edge			1	μs
t ₄	Input hold time VIDA, VIDB, VIDC valid	VIDS rising edge	20			μs
t ₅	Delay to beginning of IDAC_OUT transition	Measured from VIDS rising edge		6.3	10	μs
t ₆	IDAC_OUT transition time	Time constant for exponential rise		40		μs
t ₇	Minimum hold time in 4-bit mode	VIDA, VIDB, VIDC, VIDS		4.4		μs

⁽³⁾ For VID timing, see TIMING DIAGRAM



TIMING DIAGRAM

6 BIT MODE TIMING

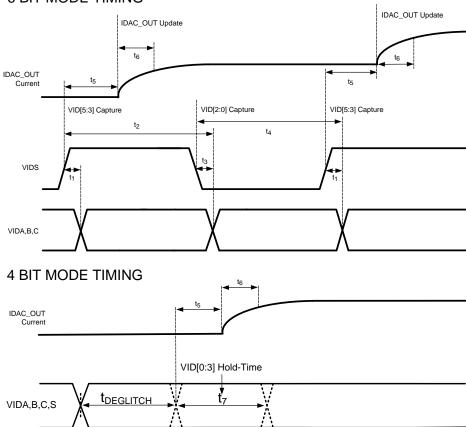
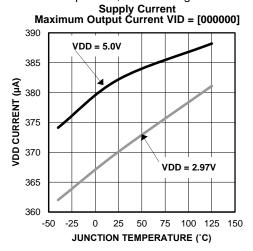


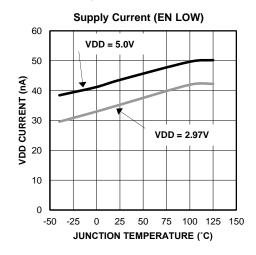
Figure 1. Timing Diagram for LM10011 Communications

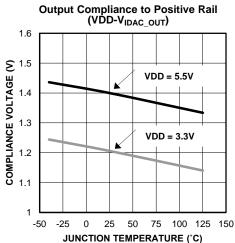
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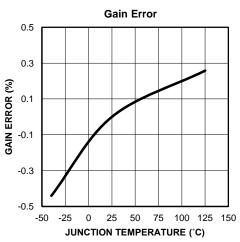
TYPICAL PERFORMANCE CHARACTERISTICS

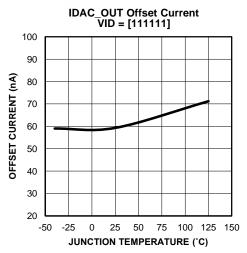
Unless otherwise specified, the following conditions apply: $T_J = 25$ °C, VDD = 5V. All graphs show junction temperature.







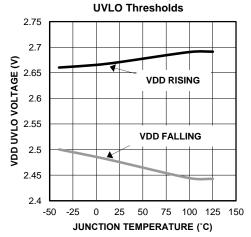


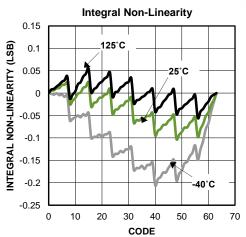


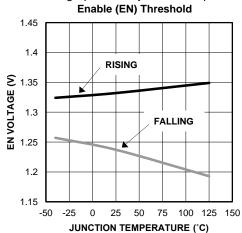


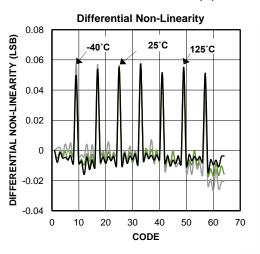
TYPICAL PERFORMANCE CHARACTERISTICS (continued)

Unless otherwise specified, the following conditions apply: $T_J = 25$ °C, VDD = 5V. All graphs show junction temperature.











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BLOCK DIAGRAM

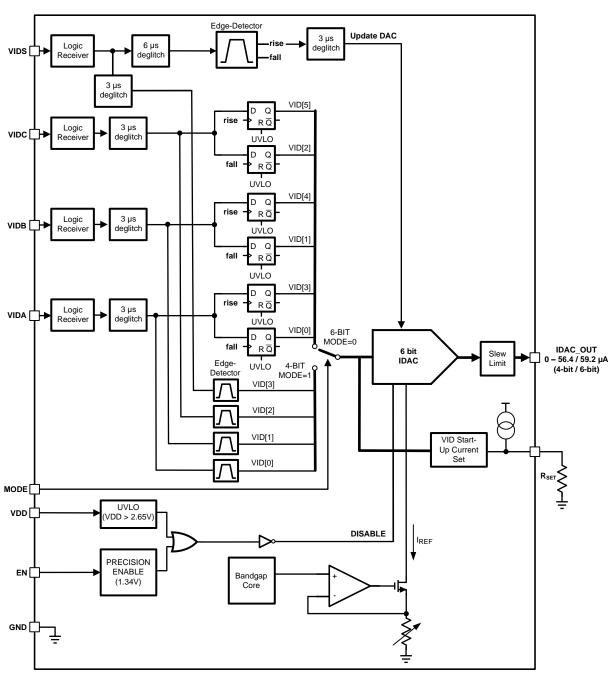


Figure 2. LM10011 Block Diagram

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FUNCTIONAL DESCRIPTION

GENERAL

The LM10011 is a precision current DAC used for controlling any point of load regulator with an adjustable resistor feedback network. Four VID communication lines (VIDA,B,C,S) are used to write a 6-bit or 4-bit VID value. The output of the IDAC (IDAC_OUT) is used to inject a precision current into the feedback node of a regulator, thus adjusting the output voltage. With this method, it is possible to precisely control the output voltage of the regulator.

An enable pin (EN) is provided to allow for a reduced quiescent current when not in use. Also, the VDD line is monitored so that an under-voltage event will shut-down the LM10011 (IDAC_OUT = 0.0μ A).

The device is available in a 10-pad No-Pullback Package (SON-10). The LM10011 can be used in numerous applications with regulators from 2.97V to 5.5V supplies. A block diagram of the LM10011 is shown in Figure 2.

THEORY OF OPERATION

The LM10011 can be treated as a D/A converter, converting digital VID codes to analog outputs. The LM10011 DAC analog output is a current that flows out of the IDAC_OUT pin. The IDAC_OUT pin is intended to be connected to the feedback node of a voltage regulator as shown in Figure 3. In a typical voltage regulator, the current in R_{FB2} is constant by virtue of the regulator feedback loop maintaining the reference voltage at the feedback node. The current flowing through R_{FB2} is the same current flowing through R_{FB1} . When current is injected into the feedback node by the LM10011, less current is required from the R_{FB1} resistor. The consequence of this is that the output voltage of the regulator will decrease to maintain the total amount of current in R_{FB2} in order to regulate at the correct feedback (reference) voltage.

Each VID code corresponds to a different IDAC_OUT current and thus a different output voltage. Increasing the VID code lowers the IDAC_OUT current and raises the output voltage. Decreasing the VID code raises the IDAC_OUT current and lowers the output voltage. All VID codes are decoded into a 6-bit or 4-bit current DAC output whether the MODE equals 0 (connected to GND) or 1 (connected to VDD).

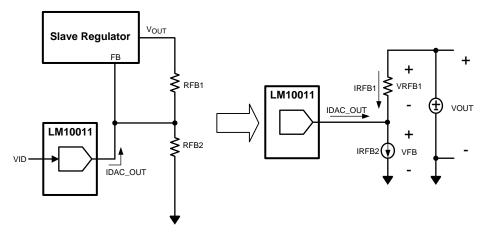


Figure 3. Output Voltage (VOUT) is Controlled Via Current Injection into the Feedback Node

CURRENT DAC

The LM10011 current DAC is based on a low voltage bandgap reference setting a current through a precision adjustable resistor. This bandgap is trimmed for precision and gives excellent performance over temperature. The output current has a maximum full-scale range [VID = 000000b] of 59.2 μ A and is adjustable with a 6/4-bit VID word. This allows for 64/16 settings, with a resolution of 940nA / 3.76 μ A respectively. The current DAC also has a slew limit to prevent abrupt changes in the output. The slew limit is represented as a time constant, t₆ = 40 μ s, in the Electrical Characteristics table. A deglitch filter for the VID inputs provides noise immunity and effectively adds a small delay from the transition of a VID line to the change in IDAC_OUT current.

VID PROGRAMMING, 6-BIT MODE

Four pins are used to communicate with the LM10011. In 6-bit mode (MODE=0), VIDA, VIDB, and VIDC are data lines, while VIDS is a latching strobe that programs in the LM10011 data. As shown in the timing diagram in Figure 1, the falling edge of VIDS latches in the data from VIDA, VIDB, and VIDC as the lower three LSB of the IDAC_OUT value, [2:0]. After a minimum hold time (t_2), the rising edge of VIDS latches in the data from VIDA, VIDB, and VIDC as the upper three LSB of the IDAC_OUT value, [5:3]. Internally, a delay (t_3 , t_1) on VIDS allows for the setting of all VIDA,B,C lines to change simultaneously as VIDS rises or falls.

VID PROGRAMMING, 4-BIT MODE

The LM10011 includes a 4-bit mode to facilitate parallel VID communication. In 4-bit mode (MODE=1), VIDC, VIDB, VIDA and VIDS are all parallel data lines. As shown in the timing diagram in Figure 1, a changing edge of any of the VID communication lines will change the IDAC_OUT current to the corresponding new 4-bit value found on the data lines. There is a 3 μ s deglitch filter to eliminate spurious noise events. The data must overcome the deglitch time and the minimum hold time (t_7) or else the IDAC_OUT pin current may not reflect the value indicated at the VID data inputs. During the hold time, no other data line can be transitioned.

As mentioned in a previous section, for both the 4-bit and 6-bit mode, the VID data word is set so that the lowest output current is seen at the highest VID data word (59.2μ A at a code of 0d in 6-bit mode and 56.4μ A in 4-bit mode). Conversely, the lowest current is seen at the highest VID data word (0.06μ A at 63d/15d). During VID operation with the regulator, this will translate to the lowest output voltage with the lowest VID word, 0d, and the highest output voltage with the highest VID word, 63d or 15d. The communications pins can be used with a low voltage microcontroller, with a maximum V_{II} of 0.75V and a minimum V_{IH} of 1.0V.

PROGRAMMING THE START-UP CURRENT

Depending on the value of R_{SET} during start-up (when VDD>VUVLO_R and EN>VEN), the output current on the IDAC_OUT pin will take on one of 16 discrete values corresponding to the currents available in the 4-bit mode. These discrete start-up currents can be programmed by connecting a resistor (R_{SET}) from the SET pin to GND. If the EN voltage is toggled or a UVLO is triggered during operation, the current will default back to the value set by the R_{SET} resistor. It takes only one VID command transition in either 4-bit or 6-bit mode to change the current to something other than the pre-programmed start-up current. The required R_{SET} resistors and their corresponding start-up currents codes can be found in Table 1.

Table 1. Start-Up / 4-Bit Mode Currents with Corresponding R_{SET} Values and Output Currents.

VID Code	Nominal IDAC_OUT Current (μA)	R _{SET} (kΩ)
0000b (0d)	56.4	0
0001b (1d)	52.7	21.0
0010b (2d)	48.9	35.7
0011b (3d)	45.2	51.1
0100b (4d)	41.4	71.5
0101b (5d)	37.7	86.6
0110b (6d)	33.9	105
0111b (7d)	30.1	118
1000b (8d)	26.4	140
1001b (9d)	22.6	154
1010b (10d)	18.8	169
1011b (11d)	15.1	182
1100b (12d)	11.3	200
1101b (13d)	7.59	215
1110b (14d)	3.80	237
1111b (15d)	0.06	301

INSTRUMENTS

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Codes 0100b (4d) through 1110b (14d) will start-up into either the selected code or 1 code higher. This means that the output voltage of the POL may start-up into the selected output voltage or 1 LSB higher.

ENABLE PIN AND UVLO

The enable (EN) pin allows the output of the device to be enabled or disabled (IDAC_OUT = 0.0µA) with an external control signal. This pin is a precision analog input that enables the device when the voltage exceeds 1.34V. The EN pin has 100 mV of hysteresis and will disable the output when the enable voltage falls below 1.23V. If EN is not used, it can be left open, and will be pulled high by an internal 2µA current source. Since the EN pin has a precise turn-on threshold it can be used along with an external resistor divider network from VDD to configure the device to turn-on at a precise input voltage.

The LM10011 has a built-in under-voltage lockout (UVLO) protection circuit that keeps the device from operating until the input voltage reaches 2.65V (typical). The UVLO threshold has 200 mV of hysteresis that keeps the LM10011 from responding to power-on glitches during start-up. Note that descending below the EN voltage and/or the UVLO voltage are functionally the same as a reset. Bringing the device back from a low enable setting or from a VDD UVLO event will reset the IDAC_OUT current to its start-up R_{SFT} setting.

Product Folder Links: LM10011

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APPLICATION INFORMATION

6-Bit MODE DESIGN EXAMPLE

In this example, an LM21215A-1 is used as the voltage regulator and the desired range of output voltage operation is 0.7V to 1.1V. The LM10011 can provide control of the output voltage within this range with 6 bits or 4 bits of resolution. For this example, the 400mV of voltage range translates to a V_{OUT_LSB} of 400mV/63 = 6.4mV (26.7mV in 4-bit mode) at the regulator output. In this calculation, 1% resistor values are used. A schematic for this example is shown in Figure 4.

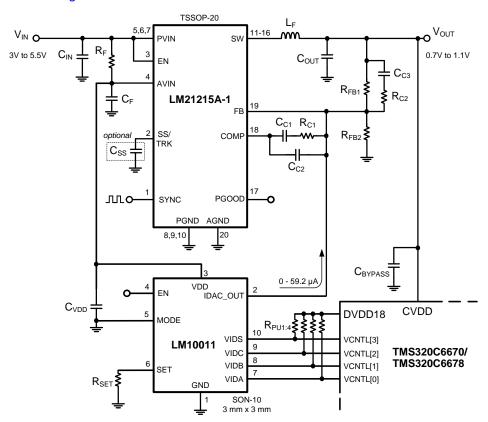


Figure 4. Typical Application Circuit

SETTING THE V_{OUT} RANGE AND LSB

Looking at the Typical Application Circuit in Figure 4, the following equation defines V_{OUT} of a given regulator (valid for $V_{OUT} > V_{FB}$):

$$V_{OUT} = V_{FB} x \left(1 + \frac{R_{FB1}}{R_{FB2}}\right) - IDAC_OUT x R_{FB1}$$
(1)

Here, the output voltage is a function of the resistor divider from R_{FB1} and R_{FB2} . Using the LM10011, there is a current supplied by the IDAC_OUT pin that helps drive current through the feedback resistor R_{FB2} , thus lowering the necessary current supplied through R_{FB1} , and hence lowering V_{OUT} . To calculate the nominal (maximum) V_{OUT} , use an IDAC_OUT value of $0\mu A$.

The change in the output voltage can be analyzed based on the resolution of the current DAC from the LM10011 compared to the desired resolution of the output swing of the regulator. R_{FB1} is designed to provide the desired $V_{OUT\ LSB}$ with the equation:

$$V_{OUT_LSB} = LSB \times R_{FB1}$$
 (2)

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Where LSB = LSB_6 (940nA) from the EC table. Based on the desired nominal V_{OUT} (with IDAC_OUT = 0 μ A) and the calculated R_{FB1} from Equation 2, R_{FB2} can be solved using Equation 1.

4-Bit MODE DESIGN EXAMPLE

Designing with the LM10011 in 4-bit mode is similar to designing in 6-bit mode. The only differences are the LSB value (LSB = LSB_4= 3.76μ A) in Equation 2 and full scale current range (IDAC_OUT = 56.4μ A).

Setting the Start-Up Voltage with R_{SET}

 R_{SET} is chosen depending on the required start-up voltage for the particular application. The user must use Equation 3 and solve for the required IDAC_OUT by inputting the known values of R_{FB1} and R_{FB2} , V_{FB} , and the desired start-up output voltage, V_{OUT} . Once IDAC_OUT is solved for, choose an R_{SET} based on Table 1 to select a start-up code to yield a current closely matching the calculated result. Use the equation below to solve for the required IDAC_OUT value at start-up.

$$IDAC_OUT = \frac{1}{R_{FB1}} \left(V_{FB} x \left(1 + \frac{R_{FB1}}{R_{FB2}} \right) - V_{OUT} \right)$$
(3)

EXAMPLE SOLUTION

While in 6-bit mode, assuming a 400mV output range, 64 VID codes, and an IDAC LSB of $0.940\mu A$, it is desired to have a V_{OUT} with an LSB of 6.4mV and a default value of 1.1V with a 1.05V start-up voltage using an LM21215A-1 regulator ($V_{FB} = 0.6V$):

$$6.4\text{mV} = 0.940\mu\text{A} \times R_{\text{FB1}}$$

$$R_{FB1} = 6.8k\Omega$$

Using 1% standard resistor values, R_{FB1} can be set to 6.81k Ω . Now calculate R_{FB2} based on R_{FB1} and the maximum V_{OUT} of 1.1V using Equation 1.

$$1.1V = .6V \times \left(1 + \frac{6.81 k\Omega}{R_{FB2}}\right) - 0V$$

$$R_{FB2} = 8.1k\Omega$$

Using 1% standard resistor values, R_{FB2} can be set to 8.06k Ω . This will yield a regulator output range of 0.704V (CODE 0d) to 1.107V (CODE 63d). Values calculated here will be dependent on the accuracy of the regulator, the LM10011 IDAC_OUT, and the resistor values used in the circuit.

Table 2 shows the codes and some of the resultant values of the IDAC current and the corresponding regulator output voltage for the previous example.

Table 2. 6-Bit VID Codes with IDAC Current and Regulator Voltage for the Example in Figure 4.

VID Code	IDAC_OUT Current (μA)	Regulator Voltage (V)
000000b (0d)	59.2	0.704
000001b (1d)	58.3	0.710
000010b (2d)	57.4	0.716
000011b (3d)	56.4	0.729
111100b (60d)	2.87	1.087
111101b (61d)	1.93	1.094
111110b (62d)	1.00	1.100
111111b (63d)	0.06	1.107

The required IDAC_OUT value during start-up can be calculated based on the desired start-up voltage of 1.05V and the R_{FB1} and R_{FB2} resistors found in the previous calculations. Using Equation 3 to solve for the required start-up IDAC_OUT current results in a start-up current of 8.36 μ A.

IDAC_OUT =
$$\frac{1}{6.81 \text{k}\Omega} \left[0.6 \text{V x} \left[1 + \frac{6.81 \text{k}\Omega}{8.06 \text{k}\Omega} \right] - 1.05 \text{V} \right] = 8.36 \mu\text{A}$$
(8)

Choose a resistor in Table 1 that selects a start-up code that produces a current close to $8.36\mu A$. An R_{SET} of $215k\Omega$ selects a nominal start-up code of 13d yielding a current of $7.59\mu A$ and start-up voltage of 1.054V. Note that using an R_{SET} of $215k\Omega$ may also select a code of 14d (+1 LSB) yielding a current of $3.80\mu A$ and a start-up voltage of 1.081V

PC BOARD GUIDELINES

The following guidelines should be followed when designing the PC board for the LM10011:

- Place the LM10011 close to the regulator feedback pin to minimize the FB trace length.
- Place a small capacitor, C_{VDD}, (1nF) directly adjacent to the VDD and GND pins of the LM10011 to help minimize transients which may occur on the input supply line.
- The high current path from the board's input to the load and the return path should be parallel and close to each other to minimize loop inductance.
- The ground connections for the various components around the LM10011 should be connected directly to each other, and to the LM10011's GND pins, and then connected to the system ground at one point. Do not connect the various component grounds to each other through the high current ground line.
- For additional information about the operation of the regulator, please consult the respective datasheet and application notes on the respective evaluation boards.

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IDAC_OUT Current Values

Table 3. IDAC_OUT Currents and Corresponding VID Codes.

VID Code (6-Bit [4-Bit])	IDAC Current (μA)
0d	59.2
1d	58.3
2d	57.4
3d [0d]	56.4
4d	55.5
5d	54.6
6d	53.6
7d [1d]	52.7
8d	51.7
9d	50.8
10d	49.8
11d [2d]	48.9
12d	48.0
13d	47.0
14d	46.1
15d [3d]	45.2
16d	44.2
17d	43.3
18d	42.3
19d [4d]	41.4
20d	40.5
21d	39.5
22d	38.6
23d [5d]	37.7
24d	36.7
25d	35.7
26d	34.8
27d [6d]	33.9
28d	33.0
29d	32.0
30d	31.1
31d [7d]	30.1

Table 3. IDAC_OUT Currents and Corresponding VID Codes. (continued)

VID Code (6-Bit [4-Bit])	IDAC Current (μA)
32d	29.2
33d	28.2
34d	27.3
35d [8d]	26.4
36d	25.4
37d	24.5
38d	23.6
39d [9d]	22.6
40d	21.6
41d	20.7
42d	19.8
43d [10d]	18.8
44d	17.9
45d	17.0
46d	16.0
47d [11d]	15.1
48d	14.1
49d	13.2
50d	12.3
51d [12d]	11.3
52d	10.4
53d	9.50
54d	8.52
55d [13d]	7.59
56d	6.60
57d	5.70
58d	4.74
59d [14d]	3.80
60d	2.87
61d	1.93
62d	1.00
63d [15d]	0.06

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PACKAGE OPTION ADDENDUM

6-Mar-2013

PACKAGING INFORMATION

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Orderable Device	Status	Package Type	Package Drawing		Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
LM10011SD/NOPB	ACTIVE	WSON	DSC	10	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	(4)	Samples
LM10011SDX/NOPB	ACTIVE	WSON	DSC	10	4500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125		Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ Only one of markings shown within the brackets will appear on the physical device.

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PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

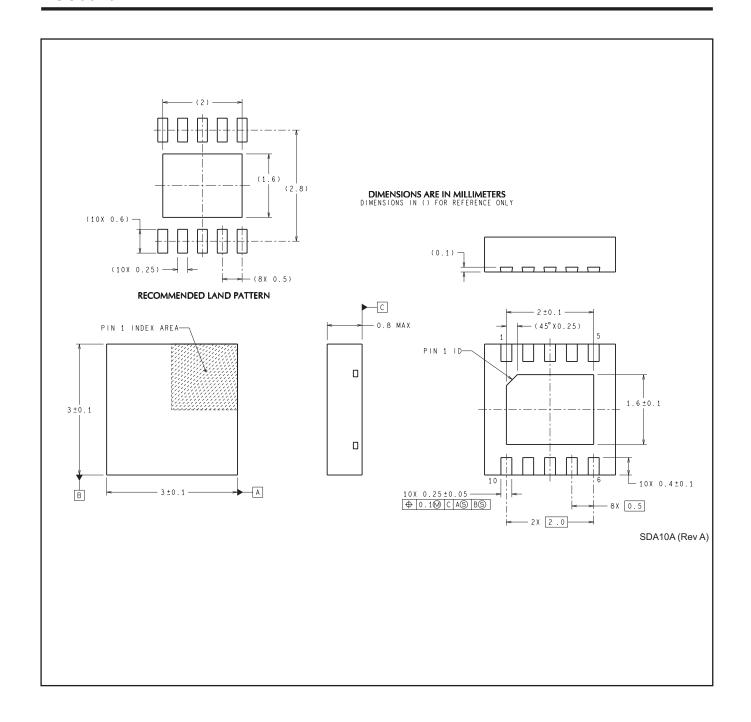
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LM10011SD/NOPB	SON	DSC	10	1000	178.0	12.4	3.3	3.3	1.0	8.0	12.0	Q1
LM10011SDX/NOPB	SON	DSC	10	4500	330.0	12.4	3.3	3.3	1.0	8.0	12.0	Q1

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LM10011SD/NOPB	SON	DSC	10	1000	203.0	190.0	41.0
LM10011SDX/NOPB	SON	DSC	10	4500	358.0	343.0	63.0



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